


<b>Search Notes</b> 	<b>Application/Control No.</b> 10660683	<b>Applicant(s)/Patent Under Reexamination</b> EBISAWA, TAKASHI
	<b>Examiner</b> Patel, Jayesh A	<b>Art Unit</b> 2624

SEARCHED			
Class	Subclass	Date	Examiner
382	273,275,274,271,266,264,263,256,258	01/22/07	JP

SEARCH NOTES		
Search Notes	Date	Examiner
See attached East Search History		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner